# INTEGRATED CIRCUITS

# DATA SHEET

# TDA4657 Generic multi-standard decoder

Preliminary specification
File under Integrated Circuits, IC02

June 1993





# **TDA4657**

# **FEATURES**

- Low voltage (8 V)
- Low power dissipation (250 mW)
- · Automatic standard recognition
- · No adjustments required
- Reduced external components
- Not all time constants integrated (ACC, SECAM de-emphasis).

# **GENERAL DESCRIPTION**

The TDA4657 is a monolithic integrated multi-standard colour decoder for PAL, SECAM and NTSC 4.43 MHz with negative colour difference output signals. It is adapted to the integrated baseband delay line TDA4660/61.

# **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply				•	•	
V <sub>P</sub>	supply voltage		7.2	8.0	8.8	V
I <sub>P</sub>	supply current	V <sub>P</sub> = 8.0 V; without load	25	31	37	mA
P <sub>tot</sub>	total power dissipation	$V_P = 8.0 \text{ V}$ ; without load	_	248	296	mW
Inputs						
V <sub>9</sub>	chrominance input voltage (peak-to-peak value)	note 1	20	200	400	mV
V <sub>20</sub>	sandcastle input voltage		_	_	13.2	V
Outputs						
V <sub>1</sub>	colour difference output signals (peak-to-peak value)	independent of supply vo	oltage; r	note 2		
	-(R-Y) output PAL and NTSC 4.43 MHz		442	525	624	mV
	SECAM		950	1050	1150	mV
V <sub>3</sub>	-(B-Y) output PAL and NTSC 4.43 MHz		559	665	791	mV
	SECAM		1200	1330	1460	mV

# Notes to the quick reference data

- 1. Within 2 dB output voltage deviation.
- 2. Burstkey width 4.3  $\mu s$  Burst width 2.25  $\mu s$ , ratio burst chrominance amplitude 1/2.2.

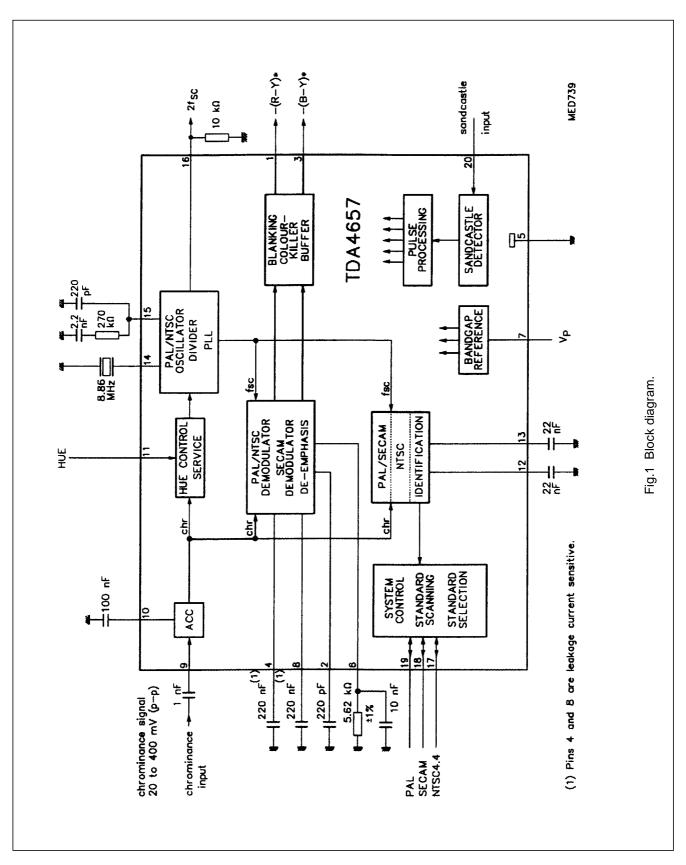
# **ORDERING INFORMATION**

EXTENDED			PACKAGE	
TYPE NUMBER	PINS	PIN POSITION	MATERIAL	CODE
TDA4657	20	DIL	plastic	SOT146 <sup>(1)</sup>
TDA4657T	20	SO	plastic	SOT163A <sup>(2)</sup>

# Note

SOT146-1; 1996 November 26.
 SOT163-1; 1996 November 26.

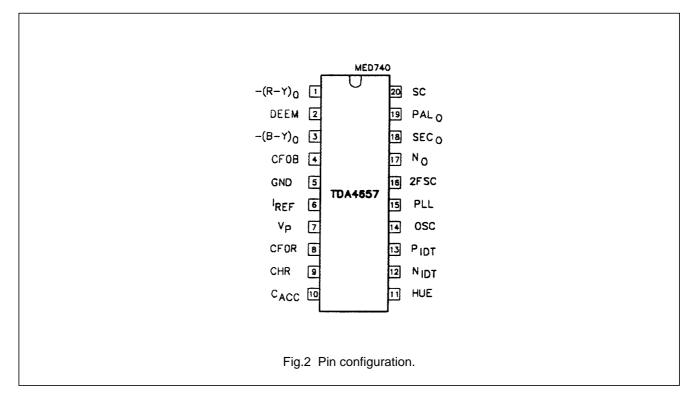
TDA4657



TDA4657

# **PINNING**

SYMBOL	PIN	DESCRIPTION
-(R-Y) <sub>O</sub>	1	colour difference signal output –(R–Y)* for baseband delay line
DEEM	2	external capacitor for SECAM de-emphasis
-(B-Y) <sub>O</sub>	3	colour difference signal output –(B–Y)* for baseband delay line
CFOB	4	external capacitor SECAM demodulator control (B-Y) Channel
GND	5	ground
I <sub>REF</sub>	6	external resistor for SECAM oscillator
V <sub>P</sub>	7	supply 8 V
CFOR	8	external capacitor SECAM demodulator control (R-Y) Channel
CHRI	9	chrominance signal input
C <sub>ACC</sub>	10	external capacitor for ACC control
HUE	11	input for HUE control and service switch
N <sub>IDT</sub>	12	external capacitor for identification circuit (NTSC)
P <sub>IDT</sub>	13	external capacitor for identification circuit (PAL and SECAM)
osc	14	PAL crystal
PLL	15	external loop filter
2FSC	16	2×f <sub>sc</sub> output
N <sub>o</sub>	17	standard setting input/output for NTSC 4.43
SECo	18	standard setting input/output for SECAM
PALo	19	standard setting input/output for PAL
SC	20	sandcastle input



# Generic multi-standard decoder

TDA4657

### **FUNCTIONAL DESCRIPTION**

The IC contains all functions required for the identification and demodulation of signals with the standards PAL, SECAM and NTSC 4.3 with 4.43 MHz colour-carrier frequency. When an unknown signal is fed into the input, the circuit has to detect the standard of the signal, and has to switch on successively the appropriate input filter and demodulator and finally, after having identified the signal, it has to switch on the colour and, in event of NTSC reception, the hue control. At the outputs the two colour difference signals  $-(R-Y)^*$  and  $-(B-Y)^*$  are available.

# **ACC** stage

The chrominance signal is fed into the asymmetrical input (pin 9) of the ACC stage (Automatic Colour Control). The input has to be AC coupled and has an input impedance of  $20~\text{k}\Omega$  in parallel with 10 pF.

To control the chrominance amplitude the modulation independent burst amplitude is measured during the burstkey pulse which is derived from the sandcastle pulse present at pin 20. The generated error current is fed into an external storage capacitor at pin 10. The integrated error voltage controls the gain of the ACC stage so that its output is independent of input signal variations.

The measurement is disabled during the vertical blanking to avoid failures because of missing burst signals.

# Reference signal generation

The reference signal generation is achieved by a PLL system. The reference oscillator operates at twice the colour-carrier frequency and is locked on the burst of the chrominance signal (chr). A divider provides reference signals ( $f_{sc}$ ) with the correct phase relationship for the PAL/NTSC demodulator and the identification part. In the SECAM mode the two  $f_0$  frequencies are derived from the PAL crystal frequency by special dividers. In this mode the oscillator is not locked to the input signal. In the NTSC mode the hue control circuit is switched between ACC stage and PLL. The phase shift of the signal can be controlled by a DC voltage at pin 11. The hue control circuit is switched off during scanning.

The reference frequency  $(2 \times f_{sc})$  is available at pin 16 to drive a PAL comb filter for example.

# Demodulation

The demodulation of the colour signal requires two demodulators. One is common for PAL and NTSC signals, the other is for SECAM signals.

The PAL/NTSC demodulator consists of two synchronized demodulators, one for the (B–Y) Channel and the other for

the (R–Y) Channel. The required reference signals ( $f_{sc}$ ) are input from the reference oscillator. In NTSC mode the PAL switch is disabled.

The SECAM demodulator consists of a PLL system. During vertical blanking the PLL oscillator is tuned to the  $f_0$  frequencies to provide a fixed black level at the demodulator output. During demodulation the control voltages are stored in the external capacitors at pins 4 and 8.

The oscillator requires an external resistor at pin 6. Behind the PLL demodulator the signal is fed into the de-emphasis network which consists of two internal resistors (2.8 k $\Omega$  and 5.6 k $\Omega$ ) and an external capacitor connected at pin 2 (220 pF).

After demodulation the signal is filtered and then fed into the next stage.

### Blanking, colour killer, buffers

As a result of using only one demodulator in SECAM mode the demodulated signal has to be split up in the (B–Y) Channel and the (R–Y) Channel. The unwanted signals occurring every second line, (R–Y) in the (B–Y) Channel and (B–Y) in the (R–Y) Channel, have to be blanked. This happens in the blanking stage by an artificial black level being inserted alternately every second line.

To avoid disturbances during line and field flyback these parts of the colour differential signals are blanked in all modes.

When no signal has been identified, the colour is switched off (signals are blanked) by the colour killer.

At the end of the colour channels are low-ohmic buffers (emitter followers). The CD output signals  $-(B-Y)^*$  and  $-(R-Y)^*$  are available at pins 1 and 3.

# Identification and system control

The identification part contains three identification demodulators.

The first demodulates in PAL mode. It is only active during the burstkey pulse. The reference signal ( $f_{sc}$ ) has the (R-Y) phase.

The second demodulator (PLL system) operates in SECAM mode and is active also during the burstkey pulse, but delayed by 2  $\mu$ s.

The PLL demodulator discriminates the frequency difference between the unmodulated  $f_0$  frequencies of the incoming signal (chr) and the reference frequency input from the crystal oscillator.

These two demodulators are followed by an H/2 switch 'rectifying' the demodulated signal. The result is an identification signal (P<sub>IDT</sub>, pin 13) that is positive for a PAL signal in PAL mode, for a SECAM signal in SECAM mode

# Generic multi-standard decoder

TDA4657

and for a PAL signal in NTSC 4.4 mode. If  $P_{IDT}$  is positive in SECAM mode, the scanner switches back to the PAL mode in order to prevent a PAL signal being erroneously identified as a SECAM signal (PAL priority).

If then  $P_{IDT}$  is not positive, the scanner returns to SECAM mode and remains there if  $P_{IDT}$  is positive again. In the event of a field frequency of 60 Hz the signal can not be identified as a SECAM signal, even if  $P_{IDT}$  is positive. In this event the scanner switches forward in the NTSC 4.4 mode. If the H/2 signal has the wrong polarity, the identification signal is negative and the H/2 flip-flop is set to the correct phase.

The third demodulator operates in NTSC mode and is active during the burstkey pulse. The resulting identification signal ( $N_{\text{IDT}}$ , pin 12) is positive for PAL and NTSC 4.4 signals in NTSC 4.4 mode. The reference signal has the (B–Y) phase.

The two identification signals allow an unequivocal identification of the received signal. In the event of a signal being identified, the scanning is stopped and after a delay time the colour is switched on.

The standard outputs (active HIGH) are available at the

pins 17, 18 and 19. During scanning the HIGH level is 2.5 V and when a signal has been identified the HIGH level is switched to 6 V. The standard pins can also be used as inputs in order to force the IC into a desired mode (Forced Standard Setting).

# Sandcastle detector and pulse processing

In the sandcastle detector the super sandcastle pulse (SC) present at pin 20 is compared with three internal threshold levels by means of three differential amplifiers. The derived signals are the burstkey pulse, the horizontal blanking pulse and the combined horizontal and vertical blanking pulse. These signals are processed into various control pulses required for the timing of the IC.

# Bandgap reference

In order to ensure that the CD output signals and the threshold levels of the sandcastle detector are independent of supply voltage variations a bandgap reference voltage has been integrated.

# **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
T <sub>stg</sub>	storage temperature		-25	+150	°C
T <sub>amb</sub>	operating ambient temperature	0	+70	٥	
$V_{P}$	supply voltage		-	8.8	V
P <sub>tot</sub>	power dissipation	without load	_	330	mW
V <sub>20</sub>	voltage at pin 20	$I_{max} = 10 \mu A$	_	15	٧
	voltage at all other pins	I <sub>max</sub> = 100 μA	-	$V_P + V_{be}$	٧

# THERMAL RESISTANCE

SYMBOL	PARAMETER	THERMAL RESISTANCE
R <sub>th j-a</sub>	thermal resistance on printed-circuit board from junction to ambient in free air (without heat spreader)	
	SO 20	90 K/W
	DIL 20	70 K/W

TDA4657

# **CHARACTERISTICS**

Measured with application circuit (Fig.4) at  $T_{amb}$  = +25 °C, 8 V supply, 75% colour bar chrominance input signal of 200 mV (peak-to-peak value) and nominal phase for NTSC unless otherwise specified. All voltages measured referenced to ground.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>P</sub>	supply voltage		7.2	8.0	8.8	V
I	supply current	V <sub>P</sub> = 8.0 V without load	25	31	37	mA
P <sub>tot</sub>	total power dissipation	V <sub>P</sub> = 8.0 V without load	_	248	296	mW
CD signal	s outputs (pins 1 and 3)		•		•	
PAL or NT	SC					
V <sub>1</sub>	colour difference output signals	independent of supp	ly voltage;	note 1		
	-(R-Y) output PAL and NTSC 4.43 MHz (peak-to-peak value)		442	525	624	mV
V <sub>3</sub>	-(B-Y) output PAL and NTSC 4.43 MHz (peak-to-peak value)		559	665	791	mV
V <sub>1</sub> /V <sub>3</sub>	ratio of CD signal amplitudes V(R-Y)/V(B-Y)	note 2	0.75	0.79	0.83	_
m	signal linearity –(R–Y) output	$V_1 = 0.8 \text{ V (p-p)}$	0.8	_	_	_
	signal linearity –(B–Y) output	V <sub>3</sub> = 1.0 V (p-p)	0.8	_	_	_
$f_g$	cut-off frequency (both outputs)	-3 dB	_	1	_	MHz
t <sub>d</sub>	chrominance delay time		220	270	320	ns
S/N	signal to noise ratio for nominal output voltages	note 3	40	_	_	dB
V <sub>1</sub> , V <sub>3</sub>	residual carrier at CD outputs  1 × subcarrier frequency (peak-to-peak value)		-	-	10	mV
	2 × subcarrier frequency (peak-to-peak value)		_	_	30	mV
	H/2 content at R-Y output at nominal input signal (peak-to-peak value)		_	_	10	mV
Α	crosstalk between CD Channels		-40	_	_	dB
R <sub>1</sub> , R <sub>3</sub>	output resistance (npn emitter follower)		_	_	200	Ω
I <sub>1</sub> , I <sub>3</sub>	output current		_	_	-3	mA

TDA4657

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
SECAM		•		!		!
V <sub>1</sub>	colour difference output signals	independent of sup	ply voltage;	note 4		
	-(R-Y) output (peak-to-peak value)		0.95	1.05	1.15	V
V <sub>3</sub>	-(B-Y) output (peak-to-peak value)		1.20	1.33	1.46	V
V <sub>1</sub> /V <sub>3</sub>	ratio of CD signal amplitudes V(R-Y)/V(B-Y)		0.75	0.79	0.83	_
m	signal linearity at nominal output voltage		0.8	_	_	<u> </u>
fg	cut-off frequency	–3 dB	_	730	_	kHz
t <sub>d</sub>	chrominance delay time		400	500	600	ns
S/N	signal to noise ratio for 100 mV (p-p) input signal and nominal output voltages	note 3	40	_	_	dB
V <sub>1</sub> , V <sub>3</sub> residual carrier at CD outputs: 1 × subcarrier frequency (peak-to-peak value)			_	_	10	mV
	2 × subcarrier frequency (peak-to-peak value)		_	_	20	mV
$\Delta V_3$	shift of demodulated f <sub>0</sub> level relative to blanking level –(B–Y) output	note 8	-	0	±13	mV
$\Delta V_1$	–(R–Y) output		_	0	±10	mV
Impedance	and currents see PAL or NTSC specification	n	•	•		
Capacitor	for SECAM de-emphasis (pin 2)					
C <sub>2</sub>	value of external capacitor		_	220	_	pF
R <sub>A</sub>	value of internal de-emphasis resistors	T <sub>amb</sub> = 35 °C	2.4	2.8	3.2	kΩ
R <sub>B</sub>			4.8	5.6	6.4	kΩ
$\Delta(R_A/R_B)$	relative tolerance of de-emphasis resistors		_	-	±5	%
Capacitor	s for SECAM demodulator control (pins 4	and 8; note 5)	•	•		•
ΔV <sub>1, 3</sub>	shift of demodulated f <sub>0</sub> level due to external leakage current	C <sub>ext</sub> = 220 nF	_	_	0.3	mV/nA
Resistor f	or SECAM oscillator (pin 6)	1				
V <sub>6</sub>	DC voltage		2.4	2.81	3.2	V
R <sub>6</sub>	value of external resistor (±1%)			5.62	_	kΩ
C <sub>6</sub>	value of external capacitor (±20%)		_	10	_	nF
	nce input (pin 9)	1			-	
V <sub>9</sub>	input signal (peak-to-peak value)	note 6	20	200	400	mV
R <sub>9</sub>	input resistance		16	20	24	kΩ
C <sub>9</sub>	input capacitance		_	1-	10	pF
-	for ACC (pin 10; note 7)	1			1	1
ΔV <sub>1, 3</sub>	change of CD output signals during field blanking due to external leakage current	C <sub>ext</sub> = 100 nF	_	0.2	_	%/nA

TDA4657

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Hue contr	ol (NTSC) and service switch (pin 11)	•	<u>'</u>	<u>'</u>	'	'
ф	phase shift of reference carrier	V <sub>11</sub> = 3 V	-30	_	_	degree
	relative to phase at open-circuit pin 11	V <sub>11</sub> = open-circuit	<b>-</b> 5	0	+5	degree
		V <sub>11</sub> = 5 V	+30	_	_	degree
V <sub>11</sub>	internal bias voltage (proportional to supply voltage)	pin 11 open-circuit	3.8	4.0	4.2	V
R <sub>11</sub>	input resistance		25	30	35	kΩ
Capacitor	for identification (pins 12 and 13)			·	•	
V <sub>12</sub> , V <sub>13</sub>	DC voltage for an identified signal		2.8	3.2	3.5	V
	DC voltage for an unidentified signal		1.5	2.0	2.3	V
PLL oscill	ator measured with nominal crystal (pin 14;	see Table 1)	'		1	'
R <sub>14</sub>	initial oscillator amplifier input resistance		-500	_	_	Ω
C <sub>14</sub>	oscillator amplifier input capacitance		_	_	10	pF
$\Delta f_{L}$	lock-in-range referenced to 4.43361875 MHz	note 9	±400	_	±1300	Hz
ф	phase difference for ±400 Hz deviation of colour carrier frequency		-	_	1	degree
2 x f <sub>sc</sub> out	<b>put</b> (pin 16; if the output is not used, the pin	should be connected	to supply)			•
V <sub>16</sub>	DC output level	I <sub>16</sub> = 0 A	6.1	6.3	6.5	V
R <sub>16</sub>	output resistance	I <sub>16</sub> = 0 A	_	_	350	Ω
I <sub>16</sub>	output current		_	_	-1.0	mA
V <sub>16</sub>	output signal (peak-to-peak value)		_	250	_	mV
Standard	setting inputs/outputs (pins 17 to 19; note	10)				
used as ou	tput: npn emitter follower output with 0.1 m/	A source to ground				
Vo	on-state, during scanning, colour OFF		2.3	2.5	2.7	V
	on-state, colour ON		5.8	6.0	6.2	V
R <sub>O</sub>	output resistance	I <sub>O</sub> = 0	_	_	300	Ω
lo	output current		_	_	-3	mA
used as in	put: forced system switching					
Vo	threshold for system ON		6.8	7.0	7.2	V
IO	input current		100	150	180	μΑ

**TDA4657** 

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Sandcast	le pulse detector (pin 20; note 11)		!	!		!
C <sub>20</sub>	input capacitance		_	_	10	pF
V <sub>20</sub>	thresholds for field and line pulse	pulse ON	1.3	1.6	1.9	V
	separation	pulse OFF	1.1	1.4	1.7	V
	line pulse separation	pulse ON	3.3	3.6	3.9	V
		pulse OFF	3.1	3.4	3.7	V
	burst pulse separation	pulse ON	5.3	5.6	5.9	V
		pulse OFF	5.1	5.4	5.7	V
System co	ontrol processing (note 12)		•		•	•
t <sub>d</sub>	system hold delay	in event of a signal disappearing for a short time	2	_	3	field periods
	colour killer; colour ON delay	switching occurs during field blanking	2	_	3	field periods
	colour OFF delay		0	_	1	field periods
t <sub>s</sub>	scanning time for each system		_	4	_	field periods

**QUALITY SPECIFICATION: URV-4-2-59/601** 

# Notes to the characteristics

- 1. Burstkey width 4.3  $\mu$ s. Burst width 2.25  $\mu$ s, ratio burst chrominance amplitude 1/2.2.
- 2. At nominal phase of hue control.
- 3. V (p-p) of signal divided by 6 times effective noise voltage.
- 4. H/2 blanking alternately every second line.
- 5. These pins are leakage current sensitive. Pin 4 for (B-Y) Channel, pin 8 for (R-Y) Channel.
- 6. Within 2 dB output voltage deviation.
- 7. This pin is leakage current sensitive.
- 8. IC only.
- 9. Depends also on network on pin 15.
- Pin 19 for PAL, pin 18 for SECAM, pin 17 for NTSC 4.43 MHz.
   Threshold levels are dependent of supply.
- 11. The field interval of the sandcastle has to be adapted to the ICs TDA2579B and TDA4690. The thresholds are independent of supply voltage.
- 12. System scanning sequence: PAL, SECAM, NTSC 4.4.

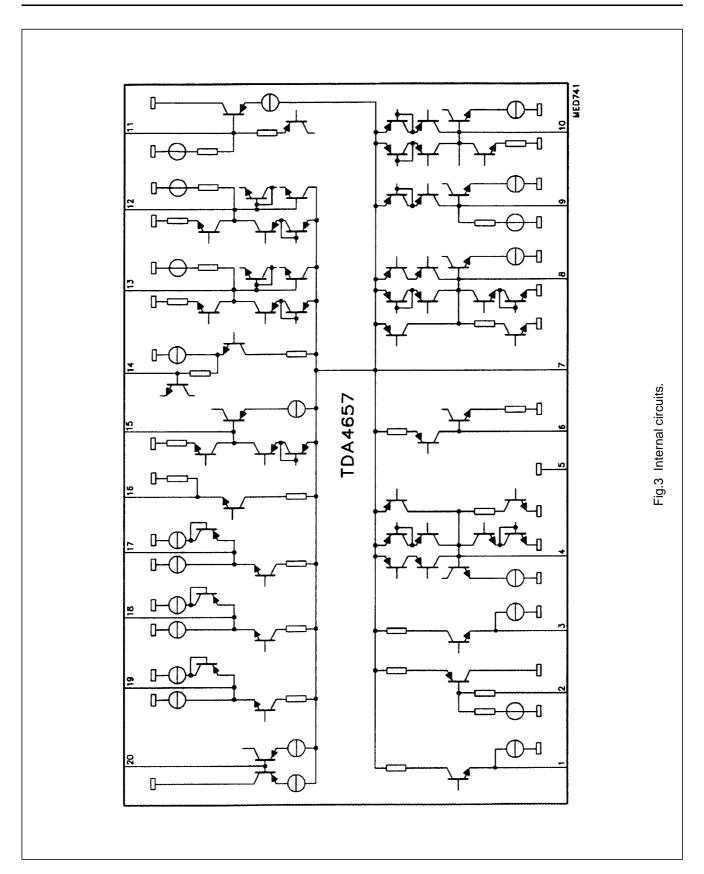
# Generic multi-standard decoder

TDA4657

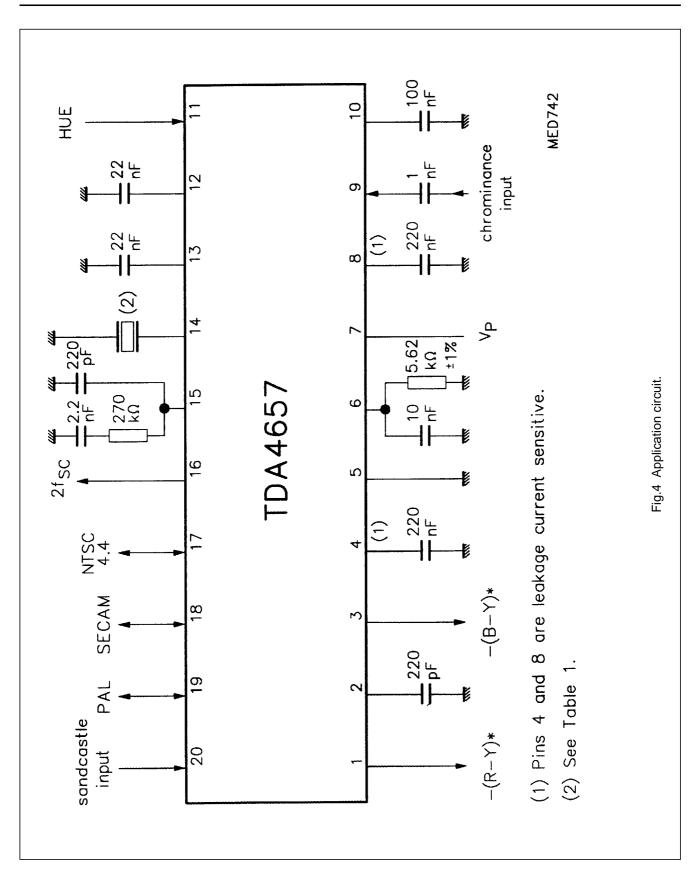
 Table 1
 Specification of quartz crystals in HC-49/U13 holder; standard application.

SYMBOL	PARAMETER	VALUE	UNIT
		9922 520 00385	
f <sub>n</sub>	nominal frequency	8.867570	MHz
C <sub>L</sub>	load capacitance	series resonance	
$\Delta f_n$	adjustment tolerance of f <sub>n</sub> at +25 °C	±20	ppm
R <sub>r</sub>	resonance resistance over temperature range	≤ 60	Ω
R <sub>dld max</sub>	in the drive level range between $10^{-12}$ W and $1.0 \times 10^{-3}$ W, the resonance resistance may not exceed (at +25 °C) the value of R <sub>dld max</sub>	tbn	Ω
R <sub>n</sub>	resonance resistance of unwanted response	2R <sub>r (+25 °C)</sub>	Ω
C <sub>1</sub>	motional capacitance (±20%)	14.0	fF
C <sub>0</sub>	parallel capacitance (±20%)	3.6	pF
T <sub>amb</sub>	operating ambient temperature	-10 to +60	°C
$\Delta f_n$	frequency tolerance over temperature	±20	ppm

TDA4657



TDA4657

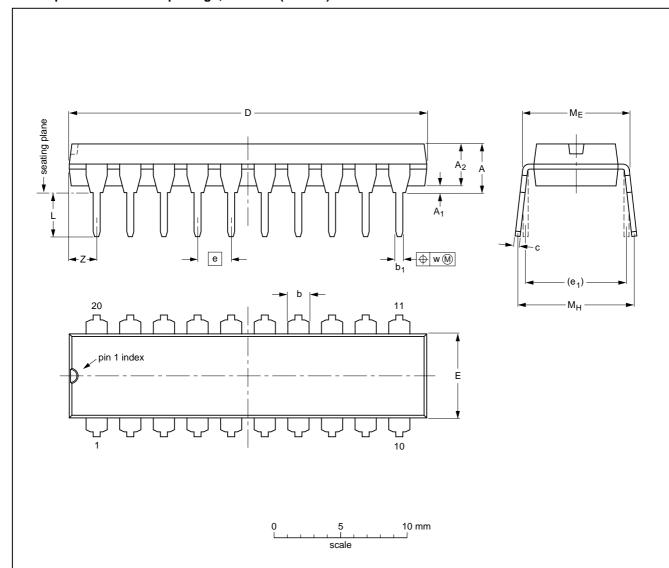


TDA4657

# **PACKAGE OUTLINES**

DIP20: plastic dual in-line package; 20 leads (300 mil)

SOT146-1



# ${\color{red} {\sf DIMENSIONS}} \ ({\sf inch \ dimensions} \ {\sf are \ derived \ from \ the \ original \ mm \ dimensions})$

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	M <sub>E</sub>	Мн	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

### Note

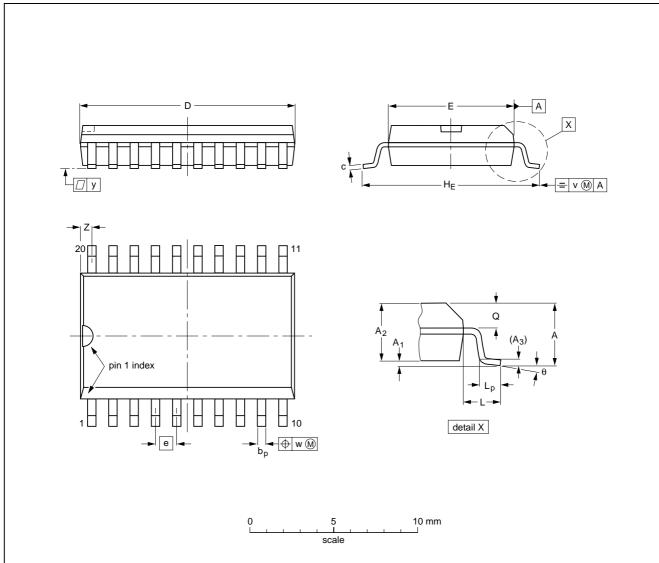
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ	PROJECTION	1330E DATE
SOT146-1			SC603	$ \  \   \bigoplus   \big($	<del>92-11-17</del> 95-05-24

TDA4657

# SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1



# **DIMENSIONS** (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	z <sup>(1)</sup>	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.36	0.32 0.23	13.0 12.6	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.51 0.49	0.30 0.29	0.050	0.419 0.394	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	0°

### Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT163-1	075E04	MS-013AC				<del>-95-01-24</del> 97-05-22	

# Generic multi-standard decoder

TDA4657

### **SOLDERING**

### Introduction

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mounted components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mounted ICs, or for printed-circuits with high population densities. In these situations reflow soldering is often used.

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our "IC Package Databook" (order code 9398 652 90011).

# DIP

SOLDERING BY DIPPING OR BY WAVE

The maximum permissible temperature of the solder is 260 °C; solder at this temperature must not be in contact with the joint for more than 5 seconds. The total contact time of successive solder waves must not exceed 5 seconds.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified maximum storage temperature (T<sub>stg max</sub>). If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

# REPAIRING SOLDERED JOINTS

Apply a low voltage soldering iron (less than 24 V) to the lead(s) of the package, below the seating plane or not more than 2 mm above it. If the temperature of the soldering iron bit is less than 300 °C it may remain in contact for up to 10 seconds. If the bit temperature is between 300 and 400 °C, contact may be up to 5 seconds.

# SO

REFLOW SOLDERING

Reflow soldering techniques are suitable for all SO packages.

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt. Dwell times vary between 50 and 300 seconds depending on heating method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 minutes at 45 °C.

### WAVE SOLDERING

Wave soldering techniques can be used for all SO packages if the following conditions are observed:

- A double-wave (a turbulent wave with high upward pressure followed by a smooth laminar wave) soldering technique should be used.
- The longitudinal axis of the package footprint must be parallel to the solder flow.
- The package footprint must incorporate solder thieves at the downstream end.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder is 10 seconds, if cooled to less than 150 °C within 6 seconds. Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

# REPAIRING SOLDERED JOINTS

Fix the component by first soldering two diagonally-opposite end leads. Use only a low voltage soldering iron (less than 24 V) applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300  $^{\circ}$ C. When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320  $^{\circ}$ C.

# Generic multi-standard decoder

**TDA4657** 

# **DEFINITIONS**

Data sheet status					
Objective specification	This data sheet contains target or goal specifications for product development.				
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.				
Product specification	This data sheet contains final product specifications.				
Limiting values					
Limiting values given are in accordance with the Absolute Maximum Dating Cyclem (IEC 424). Street above and are					

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

# **Application information**

Where application information is given, it is advisory and does not form part of the specification.

### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.